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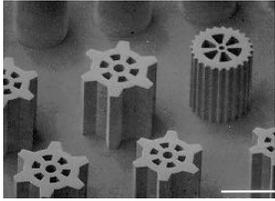
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MEMS-Based Fuze Safety and Arming Device

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Key Technology: MEMS



- **MEMS = Micro-electro-mechanical Systems**
- **Methods of MEMS Fabrication:**
 - ▷ **Low Aspect Ratio: structures 1 to 10's μ m deep**
 - surface micromachining: deposition layer(s) become structure
 - bulk micromachining: substrate becomes structure (54.7 degree angle)
 - RIE (reactive ion etching): substrate becomes structure (90 degree angle)
 - ▷ **High Aspect Ratio: 10's to 100's of μ m deep, vertical edges**
 - **LIGA** (Deep X-Ray Lithography), 200-micron **Nickel**
 - **DRIE** (Deep Reactive Ion Etching), 200-micron **Silicon**
- **For mm-sized parts transmitting forces laterally on a plane, High-Aspect-Ratio (HAR) MEMS is needed.**

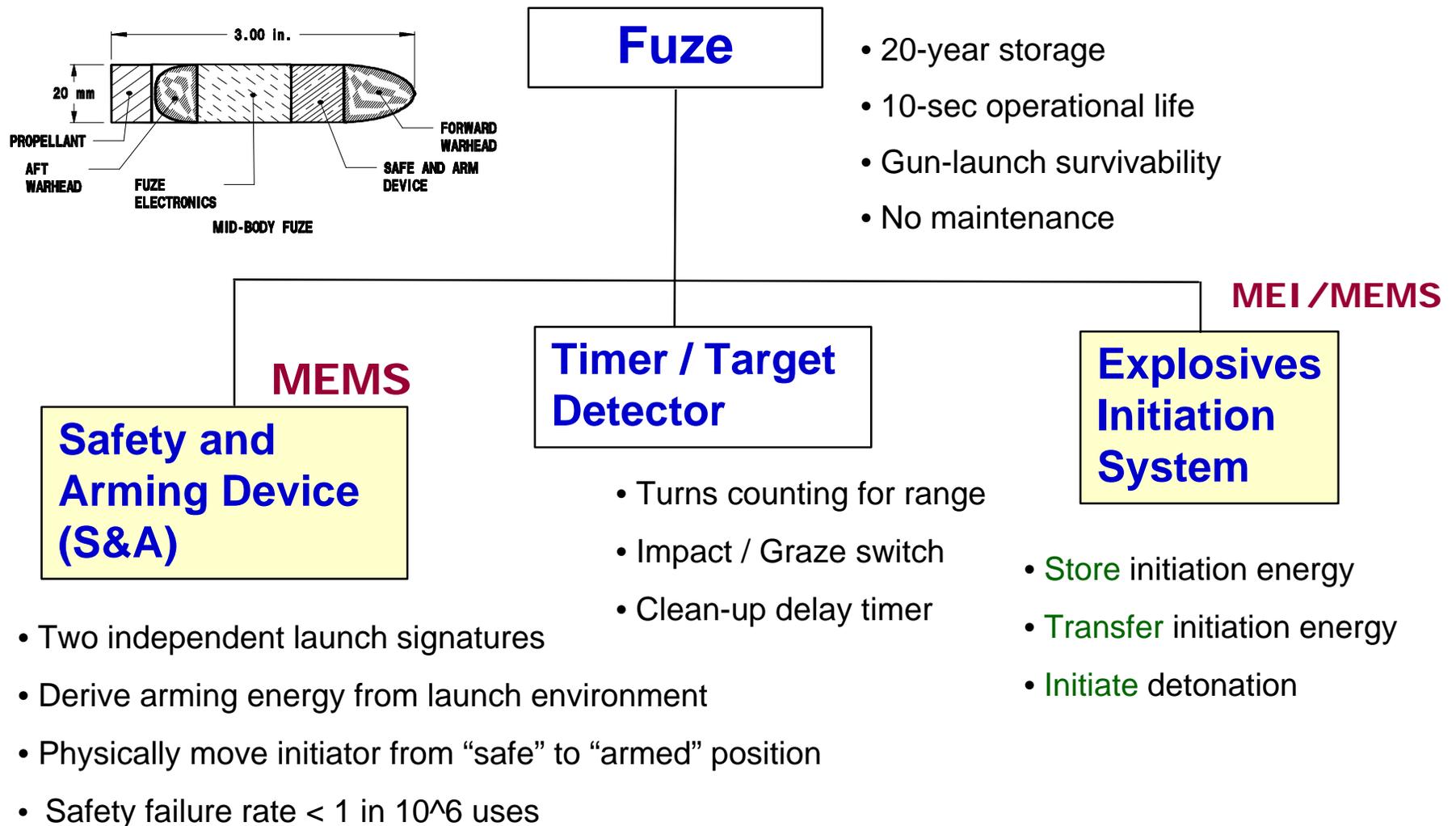


Why MEMS in Fuze Safety and Arming?

- **Low cost and miniaturization** of fuze S&As for projectile munitions
- **Reduce reliance on dwindling on-shore industrial base of small-precision-parts manufacturers, instead utilize installed micro-electronics industrial base.**
- **“Enabling” technology for special applications**
 - distributed fuze architectures (versus puck-shaped S&A)
 - **places where ESAs are currently impossible**: e.g., 20-mm fuze
 - **unpowered sensing** and recording of setback / spin
 - **“fuze on a chip”** -- 10 years out?
- **Technology transferable to other weapon platforms**
- **Meet usual requirements for logistics and handling safety** (e.g., 40-ft handling-drop) **same as “macro” designs**
- **Eliminate shelf-life problems caused by lubricants in conventional mechanical S&As** (MEMS parts require no lubrication)



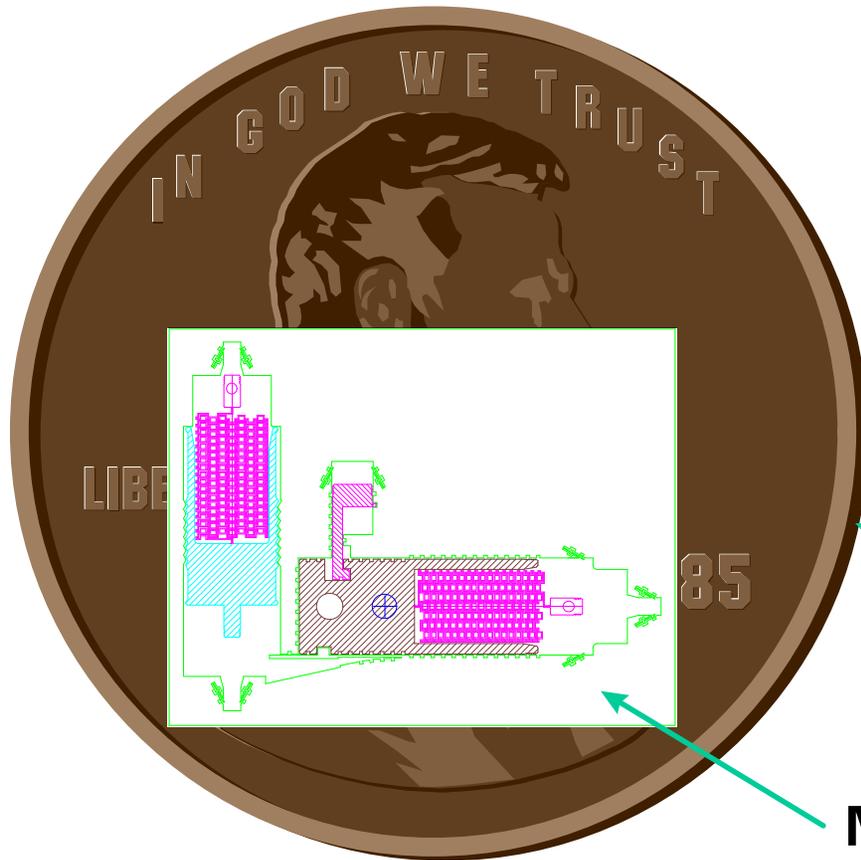
Components and Requirements of a Fuze



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How Small Can a Mechanical S&A Get?



One-Cent Coin (USA)

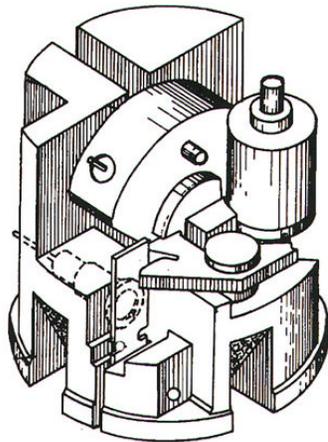
MEMS Mechanical S&A Chip

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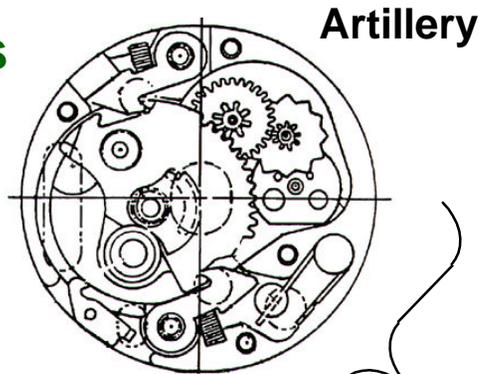


Insertion of MEMS Technology

Conventional Mechanical S&As



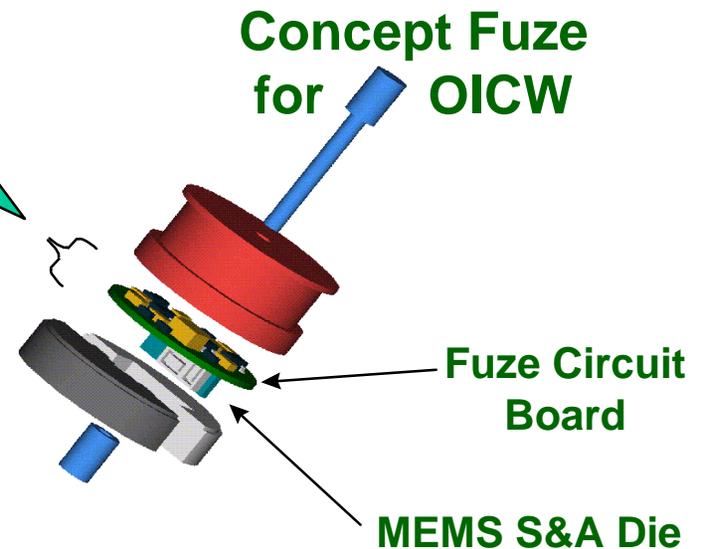
Missile



Artillery

This concept takes all the functions embodied in a conventional mechanical S&A and implements them in a single S&A die which is integrated with a fuze circuit board.

Note: a MEMS mechanical S&A is not a “sensor” per se, but rather its components intrinsically combine both sense and actuate functions in a single unpowered chip.



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MEMS Teaming Efforts to Date

- **CRADA with MCNC, FY96**
 - HI-MEMS Alliance, DARPA funding, fabrication by MCNC/CAMD
 - designed, prototyped, tested *first microscale zig-zag slider*
- **Commercial Technology Insertion Program (CTIP), FY97**
 - ONR funded, developed & prototyped *first single-chip mechanical S&A*
- **Commercial Technology Insertion Program (CTIP), FY98**
 - developing air flight sensor (AFS) for G-MLRS fuze S&A using COTS MEMS
 - mortar test of prototype AFS in FY97
- **MEMS S&A Feasibility Study, XM-80 Submunition on ERGM, FY98**
 - funded by NAVSEA through NSWC-IH Underwater Technology Division
 - developed S&A design and investigated MEMS fabrication technologies
- **DARPA/JSSAP, Development of MEMS S&A for OICW/OCSW, FY99**
 - current effort
 -

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MEMS Zig-Zag Slider:

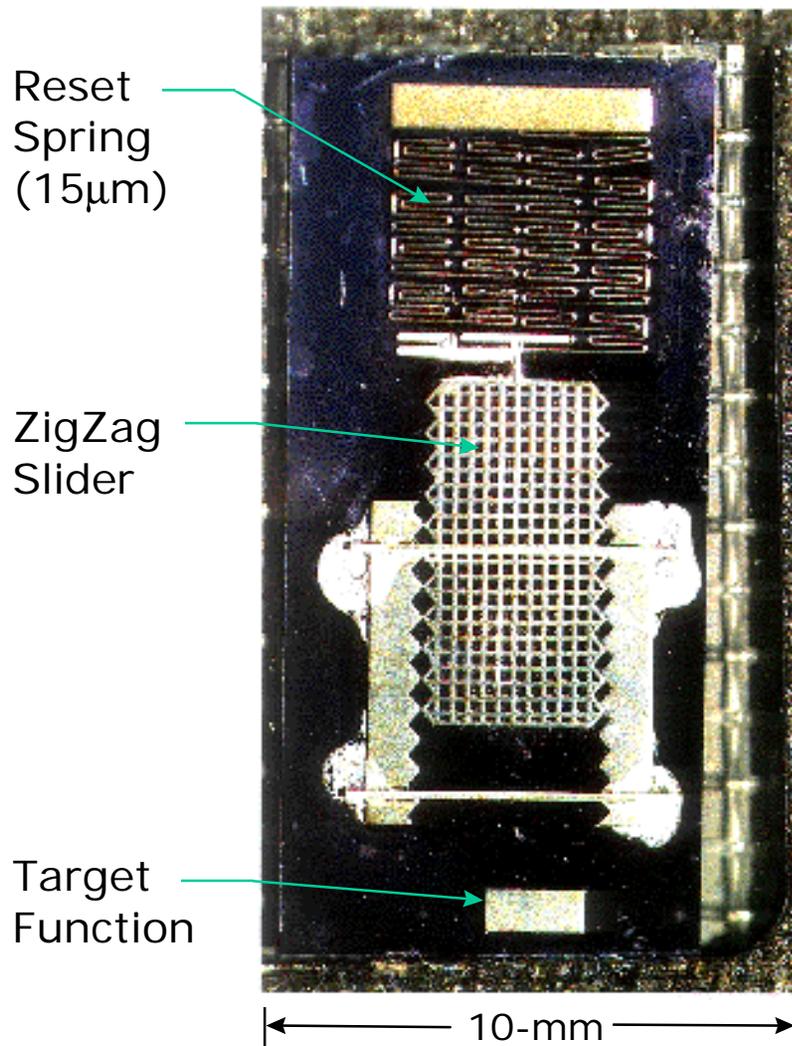
**“Inertially-Actuated,
Inertially-Damped,
Delay Slider/Actuator”**



- **small, planar vs. cylinder (historical)**
- **high-aspect-ratio MEMS**
- **design variables:**
 - **mass of slider**
 - **“throw” (about 4-mm)**
 - **number of “stages”**
 - **spring stiffness**
 - **side stroke and tooth angle**
 - **operating acceleration range**
- **design requirement:**
 - **40-ft drop safety**



Fabricated and Tested Zig-Zag Delay Device



Characteristics:

- fabricated in 200- μ m LIGA (nickel) at MCNC in 1996
- launch acceleration moves zig-zag mass down the track
- stop/start motion approximately integrates accel-time curve
- programmed delay set by number of stop/start “stages”
- spring resets mass after small inputs
- performance demonstrated in centrifuge test, July 1996
- patent No. 5,705,767



Current Efforts--Sponsorship

Development of MEMS S&A for OICW / OCSW

This Effort is Part of the OICW Systems Enhancements STO

DARPA/JSSAP Funding \$1.4M

- **OICW/OCSW MEMS Mechanical S&A**

→ 6.2-type effort to develop a MEMS mechanical S&A device for the OICW/OCSW fuze, using analysis methods, designs, and data obtained in part from the ILIR effort.

Other ARDEC Funding \$75K

- **ILIR**

→ 6.1-type effort to evolve analysis methods, designs, and test data to form the knowledge and design base for future MEMS mechanical S&A designs (not specific to the OICW)



Implementing MEMS S&A in OICW

Approach

- **Develop, demonstrate and evaluate a MEMS mechanical S&A**
- **Embody well-understood approach of existing mechanical S&As**
 - Dual independent launch signatures (provide handling safety)
 - Multiple sequential interlocks on arming slider
 - Launch-environment-driven mechanical arming
 - Consistent with MIL-STD-1316 (Fuze Safety Standards)
 - Outputs detonation wave to secondary explosive
- **Mechanical S&A is not a “sensor” but a “machine”**
 - its components intrinsically combine sense / actuate functions
- **Conduct laboratory and dynamic field test demonstrations**

Benefits

- **Reduce length/volume of S&A device**
 - allows larger warhead or reduced cartridge size
- **Reduced explosives volume in S&A may reduce hazard in manufacturing**

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MEMS S&A for OICW -- FY99

1.1 Concept Generation: requirements, architecture, action timeline

1.2 High-Aspect-Ratio MEMS Fabrication Technologies

- DRIE fabrication at MCNC/Cronos Integrated Microsystems
- LIGA and Optical-LIGA at MCNC/Chronos

1.3 Device Design and Analysis:

- design mass, spring, rotor, latch, and zig-zag test structures
- design individual components, e.g., spin latch elements
- analyze performance as medley of components

1.4 First Fabrication (June): test structures in DRIE

1.5 Second Fabrication (Nov 99): MEMS components, packaging, MEI

1.6 Device Testing: centrifuge and drop table testing

2.0 FY00-- More of same, ending in field test demonstration





Parallel Effort: Micro-Energetic Initiator (MEI)

- **The MEI is a key element for MEMS S&A designs**
- **MEMS and “macro” detonators (e.g., M100) do not mix:**
 - M100 is too large for MEMS devices to manipulate
 - MEMS chip cannot block explosive output of a detonator
- **Requirements of MEI**
 - small enough for MEMS components to manipulate
 - powerful enough to detonate secondary explosives



Summary

- **First Small Arms MEMS S&A Being Developed**
 - reducing designs to practice in DRIE or LIGA
- **Development of Micro-energetic initiator (MEI) Key Element**
- **Protection of Intellectual Property Paramount**
- **MEMS Will Reduce S&A Cost 50+%**
- **DARPA/JSSAP Co-Funding MEMS S&A Initiative**